## Notice of References Cited

Application/Control No.

10/709,543

Examiner

Michael D. Masinick

Applicant(s)/Patent Under
Reexamination
WHIFFEN ET AL.

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,437,692 B1	08-2002	Petite et al.	340/540
	В	US-2002/0059033 A1	05-2002	Batug et al.	702/24
	C	US-6,208,948 B1	03-2001	Klingler et al.	702/183
	D	US-6,553,336 B1	04-2003	Johnson et al.	702/188
	E	US-6,904,385 B1	06-2005	Budike, Jr., Lothar E. S.	702/182
	F	US-			<u> </u>
	G	US-			
	Н	US			
	ı	US-		·	:
	J	US-			
	К	US-			;
	L	US-			·
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	. Name	Classification
	N				·	:
	0					:
	Р					:
	Q					: ·
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
Y	U	"A Digital Measurement Station for RF-Conducted Emissions Monitoring" -Capua et al, IEEE Transactions on Instrumentation and Measurement, Vol 51, No. 6, IEEE December 2002.
	٧	
$\forall$	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.